

### Subject Description Form

<b>Subject Code</b>	EIE3305
<b>Subject Title</b>	Integrated Analogue and Digital Circuits
<b>Credit Value</b>	3
<b>Level</b>	3
<b>Pre-requisite</b>	EIE2100 Basic Circuit Analysis EIE2102 Basic Electronics EIE3100 Analogue Circuit Fundamentals
<b>Co-requisite/ Exclusion</b>	Nil
<b>Objectives</b>	To develop an in-depth understanding of the design principles and applications of integrated analogue and digital circuits.
<b>Intended Subject Learning Outcomes</b>	<p><b>Upon completion of the subject, students will be able to:</b></p> <p><u>Category A: Professional/academic knowledge and skills</u></p> <ol style="list-style-type: none"> <li>1. An understanding of the fundamental principles and applications of digital logic circuits.</li> <li>2. An ability to design periodic signal generators from digital logic circuits.</li> <li>3. An understanding of filter design principles and circuit technologies.</li> <li>4. An ability to apply theory and realize analog filter circuits.</li> <li>5. An understanding of output stage design of analog circuits.</li> <li>6. An overview of advanced logic circuit families.</li> </ol> <p><u>Category B: Attributes for all-roundedness</u></p> <ol style="list-style-type: none"> <li>7. An ability to communicate effectively</li> <li>8. An ability to think critically and creatively</li> <li>9. An ability to assimilate new technological development in related field</li> </ol>
<b>Subject Synopsis/ Indicative Syllabus</b>	<p><b>Syllabus:</b></p> <ol style="list-style-type: none"> <li>1. <u>Integrated Analog Circuits</u> <ol style="list-style-type: none"> <li>1.1 <i>Analog filters</i>: Filter type and specifications, transfer function, Butterworth and Chebyshev filters, first-order and second-order filter functions, passive second-order LCR filters, active second-order filters based on inductor replacement / two-integrator-loop / single-amplifier biquad, switched-capacitor filters</li> <li>1.2 <i>Waveform generators</i>: Basic principles of sinusoidal oscillators, oscillator feedback loop and oscillation criteria, op-amp-RC oscillator circuits (Wien-Bridge oscillator, phase-shift oscillator, quadrature oscillator), LC and crystal oscillators, bistable multivibrators, monostable multivibrators, 555 integrator circuit timer</li> <li>1.3 <i>Output stage design</i>: Classification of output stages, Class A / B / AB output stages, biasing circuit design, transfer characteristic, signal waveform, power dissipation and conversion efficiency, harmonic distortion</li> </ol> </li> <li>2. <u>Integrated Digital Circuits</u> <ol style="list-style-type: none"> <li>2.1 <i>CMOS logic</i>: Basic logic inverter, voltage transfer characteristic, noise margins, propagation delay, inverter sizing, power dissipation, pull-up and pull-down networks, synthesis method for CMOS logic-gate circuits, transistor sizing, fan-in and fan-out</li> <li>2.2 <i>Advanced logic circuit families – an overview</i>: Pseudo-NMOS logic, pass-transistor logic, dynamic MOS logic, emitter-coupled logic (ECL), bipolar CMOS (BiCMOS) logic</li> <li>2.3 <i>Memory circuits</i>: Flip-flop (basic principles and applications), memory-chip organization, random-access memory (RAM) – static</li> </ol> </li> </ol>

	<p>and dynamic RAM, sense amplifiers, address decoders, read-only memory (ROM) – programmable ROM (PROM), erasable PROM (EPROM), electrically EPROM (EEPROM)</p> <p><b>Laboratory Experiments:</b></p> <ol style="list-style-type: none"> <li>1. Design of Butterworth / Chebyshev filter.</li> <li>2. Sinusoidal, square-wave, and triangular waveform generators.</li> <li>3. Characterization of basic CMOS logic inverter.</li> </ol>														
<p><b>Teaching/ Learning Methodology</b></p>	<table border="1"> <thead> <tr> <th data-bbox="464 427 778 566">Teaching and Learning Method</th> <th data-bbox="778 427 963 566">Intended Subject Learning Outcome</th> <th data-bbox="963 427 1422 566">Remarks</th> </tr> </thead> <tbody> <tr> <td data-bbox="464 566 778 674">Lectures</td> <td data-bbox="778 566 963 674">1, 2, 3, 4, 5, 6</td> <td data-bbox="963 566 1422 674">Fundamental principles and key concepts of the subject are delivered to students</td> </tr> <tr> <td data-bbox="464 674 778 882">Tutorials</td> <td data-bbox="778 674 963 882">1, 2, 3, 4, 5, 6</td> <td data-bbox="963 674 1422 882">Students will be able to clarify concepts and to have a deeper understanding of the lecture material; Problems and application examples are given and discussed</td> </tr> <tr> <td data-bbox="464 882 778 1021">Laboratory sessions</td> <td data-bbox="778 882 963 1021">1, 2, 3, 4, 7, 8, 9</td> <td data-bbox="963 882 1422 1021">Students in groups of 2-3 will conduct practical measurement and evaluate the performance of electronic circuits</td> </tr> </tbody> </table>			Teaching and Learning Method	Intended Subject Learning Outcome	Remarks	Lectures	1, 2, 3, 4, 5, 6	Fundamental principles and key concepts of the subject are delivered to students	Tutorials	1, 2, 3, 4, 5, 6	Students will be able to clarify concepts and to have a deeper understanding of the lecture material; Problems and application examples are given and discussed	Laboratory sessions	1, 2, 3, 4, 7, 8, 9	Students in groups of 2-3 will conduct practical measurement and evaluate the performance of electronic circuits
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Assessment Methods in Alignment with Intended Subject Learning Outcomes	Specific Assessment Methods/Tasks	% Weighting	Intended Subject Learning Outcomes to be Assessed (Please tick as appropriate)																			
			1	2	3	4	5	6	7	8	9											
	1. Continuous Assessment (40%)																					
	• Assignment	13%	✓	✓	✓	✓	✓	✓														
	• Tests	13%	✓	✓	✓	✓	✓	✓														
	• Laboratory sessions	14%	✓	✓	✓	✓				✓	✓	✓										
	2. Examination	60%	✓	✓	✓	✓	✓	✓	✓	✓	✓	✓	✓	✓								
	Total	100%																				
<p>The continuous assessment consists of assignments, quizzes and two tests.</p> <p><b>Explanation of the appropriateness of the assessment methods in assessing the intended learning outcomes:</b></p> <table border="1"> <thead> <tr> <th>Specific Assessment Methods/Tasks</th> <th>Remark</th> </tr> </thead> <tbody> <tr> <td>Short quizzes</td> <td>Mainly objective tests (e.g., multiple-choice questions, true-false, and matching items) conducted to measure the students' ability to remember facts and figures as well as their comprehension of subject materials</td> </tr> <tr> <td>Tests and examination</td> <td>End-of chapter type problems used to evaluate students' ability in applying concepts and skills learnt in the classroom; Students need to think critically and creatively in order to come with an alternate solution for an existing problem</td> </tr> <tr> <td>Laboratory sessions</td> <td>Each group of students are required to produce a written report; Accuracy and the presentation of the report will be assessed</td> </tr> </tbody> </table>															Specific Assessment Methods/Tasks	Remark	Short quizzes	Mainly objective tests (e.g., multiple-choice questions, true-false, and matching items) conducted to measure the students' ability to remember facts and figures as well as their comprehension of subject materials	Tests and examination	End-of chapter type problems used to evaluate students' ability in applying concepts and skills learnt in the classroom; Students need to think critically and creatively in order to come with an alternate solution for an existing problem	Laboratory sessions	Each group of students are required to produce a written report; Accuracy and the presentation of the report will be assessed
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Student Study Effort Expected	<b>Class contact (time-tabled):</b>																					
	• Lecture													24 Hours								
	• Tutorial/Laboratory/Practice Classes													15 hours								
	<b>Other student study effort:</b>																					
	• Lecture: preview/review of notes; preparation for test/quizzes/examination													36 Hours								
	• Tutorial/Laboratory/Practice Classes: preview of materials, revision and/or reports writing													30 Hours								
<b>Total student study effort:</b>													<b>105 Hours</b>									

<b>Reading List and References</b>	<p><b>Textbooks:</b></p> <ol style="list-style-type: none"> <li>1. Adel S. Sedra and Kenneth C. Smith, <i>Microelectronic Circuits</i>, 6<sup>th</sup> ed., Oxford University Press, 2011.</li> <li>2. Jacob Millman and Arvin Grabel, <i>Microelectronics</i>, 2<sup>nd</sup> ed., McGraw-Hill, 1987.</li> </ol> <p><b>Reference Books:</b></p> <ol style="list-style-type: none"> <li>1. Thomas L. Floyd, <i>Digital Fundamentals</i>, 10<sup>th</sup> ed., Pearson, 2009.</li> <li>2. Rolf Schaumann and Mac E. Van Valkenburg, <i>Design of Analog Filters</i>, Oxford University Press, 2001.</li> <li>3. John P. Hayes, <i>Introduction to Digital Logic Design</i>, Addison-Wesley, 1993.</li> <li>4. Paul Horowitz and Winfield Hill, <i>The Art of Electronics</i>, 2<sup>nd</sup> ed, Cambridge University Press, 1989.</li> </ol>
<b>Last Updated</b>	May 2018
<b>Prepared by</b>	Dr S. C. Wong